

HELIOS EF for I μ S 3.0

- Superfocusing - for "best-ever" microfocus sealed tube intensity

The desire to investigate smaller, more weakly diffracting samples continuously pushes X-ray source and optics development to new heights. We therefore designed the new HELIOS EF optics for copper K α radiation to deliver a highly focused beam with maximum intensity. HELIOS EF optics were developed for the I μ S 3.0 microfocus X-ray source, the only microfocus X-ray source optimized for the needs of crystallography.

- The HELIOS EF optics and I μ S 3.0 combination features the highest flux density of any sealed tube microfocus source in a small highly focused beam.
- The HELIOS EF optics will deliver the best data for your small, most weakly diffracting samples from coordination and organic chemistry as well as smaller biological samples.

Sealed under helium


HELIOS EF optics are manufactured with the highest possible precision to deliver the greatest flux density and best monochromaticity. The Montel-type double bounce beam geometry guarantees the most homogenous beam. Mounted on an optical bench with outstanding stability, alignment of the HELIOS EF optics is fast, simple and reproducible. Like all our modern X-ray optics, the HELIOS EF mirrors are hermetically sealed under helium with a sensor permanently monitoring the pressure, making vacuum pumps for the optics housing obsolete. The HELIOS EF combines cutting-edge technology with ease-of-use, resulting in the highest performance and lowest maintenance of any optics before.

Snap-lock collimators

HELIOS EF optics are offered with a set of easily exchangeable pinhole snap-lock collimators. These highly precise pinhole collimators are ideal for fine-tuning the X-ray beam characteristics to the needs of each individual sample with excellent reproducibility. The round shape of the pinhole collimation minimizes the spot overlap and delivers a superior beam profile compared to rectangular slit setups.

| Features and Benefits | | |
|--|---|---|
| Optical principle | Montel-type optics, 90 degrees | Focusing optics designed for the needs of single crystal X-ray diffraction |
| Divergence | 13.6 mrad | Optimized for small, weakly diffracting samples |
| Intensity | $> 7.5 \times 10^{10}$ ph s ⁻¹ mm ⁻² (Cu-K α) | Most intense X-ray beam from any sealed microfocus X-ray source |
| Beam size at the focus position | ~ 0.100 mm (FWHM), round | Beam size optimized to the size of today's most challenging samples |
| Collimation for D8 QUEST and D8 VENTURE (optional) | Two Pinhole Collimators 0.2 / 6mrad, 0.3 / 10mrad, 0.3 / 17mrad, 0.6 / 21mrad | Snap-lock collimators for fast reproducible beam adjustment leading to round spots with minimized overlap |
| Protection of the optics | Helium, permanently sealed housing, 1.4 bar, pressure sensor control | Long term stability without adding cost from pressurized gas bottles or spare parts for vacuum pumps |
| Length of the optics | 15 cm | Long optics for maximum beam intensity |
| Spectral purity for K α | > 99.9 % | Best spectral purity for clear diffraction pattern |

Bruker AXS is continually improving its products and reserves the right to change specifications without notice. Order No. DOC-S86-EXS062 V4 © 2019 Bruker AXS.

 **Bruker AXS GmbH**
info.baxs@bruker.com

www.bruker.com

Worldwide offices
bruker.com/baxs-offices



Online information
bruker.com/photonIII

